Notice of References Cited Application/Control No. 10/822,960 Examiner Andy Huynh Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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	1	US-			
	J	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63244748 A	10-1988	Japan	SUETAKE, MIKIO	
	0					
	Р					
	Q					
	R					
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	Т					

NON-PATENT DOCUMENTS

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